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LM108AJAN Operational Amplifiers

Check for Samples: LM108AJAN

FEATURES

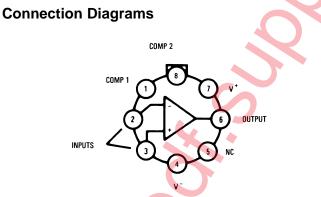
- Maximum Input Bias Current of 3.0 nA over Temperature
- Offset Current less than 400 pA over Temperature
- Supply Current of only 300 µA, even in Saturation
- Ensured Drift Characteristics

DESCRIPTION

The LM108 is a precision operational amplifier having specifications a factor of ten better than FET amplifiers over a -55° C to $+125^{\circ}$ C temperature range.

The devices operate with supply voltages from $\pm 2V$ to $\pm 20V$ and have sufficient supply rejection to use unregulated supplies. Although the circuit is interchangeable with, and uses the same compensation as the LM101A, an alternate compensation scheme can be used to make it particularly insensitive to power supply noise and to make supply bypass capacitors unnecessary.

The low current error of the LM108 makes possible many designs that are not practical with conventional amplifiers. In fact, it operates from 10 M Ω source resistances, introducing less error than devices such as the 709 with 10 k Ω sources. Integrators with drifts less than 500 μ V/sec and analog time delays in excess of one hour can be made using capacitors no larger than 1 μ F.



*Package is connected to Pin 4 (V⁻) **Unused pin (no internal connection) to allow for input anti-leakage guard ring on printed circuit board layout.

> Figure 1. Metal Can Package - TO-99 Package Number LMC

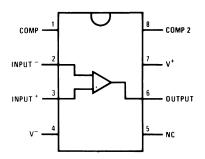


Figure 2. Dual-In-Line Package (Top View) CDIP - Package Number NAB

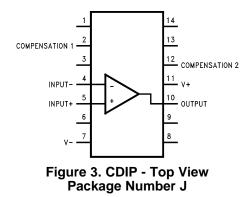
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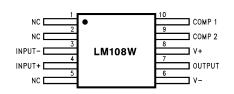
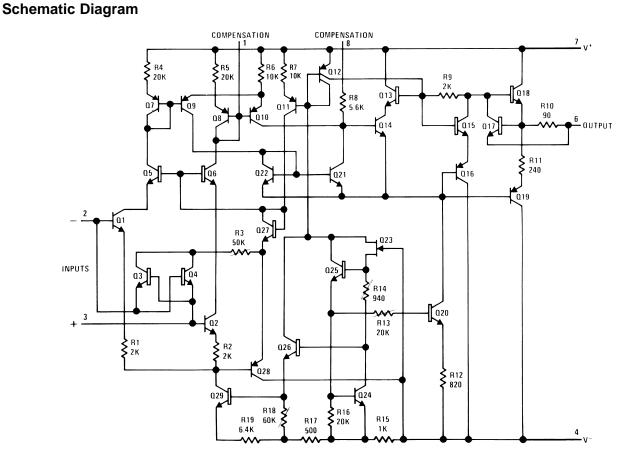


Figure 4. CLGA Top View Package Number NAC, NAD



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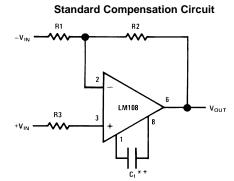
2

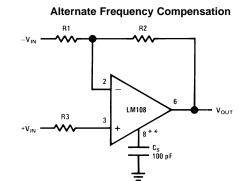


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Compensation Circuits



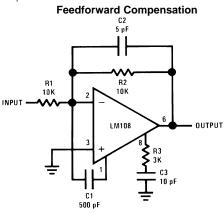


 $^{^{\}star\star}Bandwidth$ and slew rate are proportional to $1/C_S$ Improves rejection of power supply noise by a factor of ten.

$C_f \geq \frac{R1 \ C_O}{R1 \ + \ R2}$

C_O = 30 pF

**Bandwidth and slew rate are proportional to 1/C_f





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

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Absolute Maximum Ratings⁽¹⁾

| Supply Voltage | | | ±22V |
|---|-----------------|---|--------------------------------|
| | | TO-99 Metal Can 8LD | 330mW @ +125°C |
| | | CDIP 14LD | 400mW @ +125°C |
| Power Dissipation ⁽²⁾ | | CDIP 8LD | 400mW @ +125°C |
| | | CLGA 10LD | 330mW @ +125°C |
| | | Ceramic SOIC 10LD | 330mW @ +125°C |
| Differential Input Current ⁽³⁾ | | | ±10 mA |
| Differential Input Voltage ⁽⁴⁾ | | | ±30V |
| Input Voltage ⁽⁵⁾ | | | ±20V |
| Output Short-Circuit Duration | | | Continuous |
| Operating Temperature Range | | | −55°C ≤T _A ≤ +125°C |
| Storage Temperature Range | | | −65°C ≤T _A ≤ +150°C |
| | | TO-99 Metal Can 8LD Still Air 500LF / Min Air Flow | 150°C/W 86°C/W |
| | θ _{JA} | CDIP 14LD Still Air 500LF / Min Air Flow | 94°C/W 55°C/W |
| | | CDIP 8LD Still Air 500LF / Min Air Flow | 120°C/W 68°C/W |
| Theresel Designation | | CPACK 10LD Still Air 500LF / Min Air Flow | 225°C/W 142°C/W |
| Thermal Resistance | | Ceramic SOIC 10LD Still Air 500LF / Min Air Flow | 225°C/W 142°C/W |
| | | TO-99 Metal Can 8LD | 38°C/W |
| | | CDIP 14LD | 13°C/W |
| | θ_{JC} | CDIP 8LD | 17°C/W |
| | | CLGA 10LD | 21°C/W |
| | | Ceramic SOIC 10LD | 21°C/W |
| | | TO-99 Metal Can 8LD | 990mg |
| | | CDIP 14LD | 2,180mg |
| Package Weight (typical) | | CDIP 8LD | 1,090mg |
| | | CLGA 10LD | 225mg |
| | | Ceramic SOIC 10LD | 210mg |
| Maximum Junction Teperature | | | 175°C |
| Lead Temperature (Soldering, 10 sec) | | | 300°C |
| ESD Tolerance ⁽⁶⁾ | | | 2000V |

(1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. For ensured specifications and test conditions, see the Electrical Characteristics. The specified specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

(2) The maximum power dissipation must be derated at elevated temperatures and is dictated by T_Jmax (maximum junction temperature), θ_{JA} (package junction to ambient thermal resistance), and T_A (ambient temperature). The maximum allowable power dissipation at any temperature is P_Dmax = (T_Jmax - T_A) /θ_{JA} or the number given in the Absolute Maximum Ratings, whichever is lower.

(3) The inputs are shunted with back-to-back diodes for over voltage protection. Therefore, excessive current will flow if a differential input voltage in excess of 1V is applied between the inputs unless some limiting resistance is used.

(4) This rating is ±1.0V unless resistances of 2KΩ or greater are inserted in series with the inputs to limit current in the input shunt diodes to the maximum allowable value.

(5) For supply voltages less than ±20V, the absolute maximum input voltage is equal to the supply voltage.

(6) Human body model, $1.5 \text{ k}\Omega$ in series with 100 pF.



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| Table 1. Quality Conformance InspectionMil-Std-883, | Method 5005 - Group A |
|---|-----------------------|
| Table 1. Quality comornance inspectionin ota 660, | |

| Subgroup | Description | Temp (°C) |
|----------|---------------------|-----------|
| 1 | Static tests at | +25°C |
| 2 | Static tests at | +125°C |
| 3 | Static tests at | -55°C |
| 4 | Dynamic tests at | +25°C |
| 5 | Dynamic tests at | +125°C |
| 6 | Dynamic tests at | −55°C |
| 7 | Functional tests at | +25°C |
| 8A | Functional tests at | +125°C |
| 8B | Functional tests at | −55°C |
| 9 | Switching tests at | +25°C |
| 10 | Switching tests at | +125°C |
| 11 | Switching tests at | -55°C |

LM108A Electrical Characteristics DC Parameters

The following conditions apply to all the following parameters, unless otherwise specified. DC: $+V_{CC} = +20V$, $-V_{CC} = -20V$, $V_{CM} = 0V$, $R_S = 50\Omega$

| Symbol | Parameter | Conditions | Notes | Min | Мах | Units | Sub- groups |
|-------------------------|--------------------------------|---|--------------------|------|-----|-------|--|
| V _{IO} | | +V _{CC} = 35V, -V _{CC} = -5V, | | -0.5 | 0.5 | mV | 1 |
| | | $V_{CM} = -15V$ | | -1 | 1 | mV | 2, 3 |
| | | $+V_{CC} = 5V, -V_{CC} = -35V,$ $V_{CM} = 15V$ | | -0.5 | 0.5 | mV | 1 |
| | In part Offenst Malta an | | -1 | 1 | mV | 2, 3 | |
| | Input Offset Voltage | | | -0.5 | 0.5 | mV | 1 |
| | | | | -1 | 1 | mV | 2, 3 |
| | | | -0.5 | 0.5 | mV | 1 | |
| | | $+V_{CC} = +5V, -V_{CC} = -5V$ | | -1 | 1 | mV | 2, 3 |
| Delta V _{IO} / | | 25°C ≤ T _A ≤ +125°C | See ⁽¹⁾ | -5 | 5 | μV/°C | 2 |
| Delta T | | 25°C ≤ T _A ≤ -55°C | See ⁽¹⁾ | -5 | 5 | μV/°C | 3 |
| IIO | | + $V_{CC} = 35V, -V_{CC} = -5V,$ $V_{CM} = -15V$ | | -0.2 | 0.2 | nA | 1 |
| | | | | -0.4 | 0.4 | nA | 2, 3 |
| | | +V _{CC} = 5V, -V _{CC} = -35V, | | -0.2 | 0.2 | nA | 2, 3 1 2, 3 1 2, 3 2 3 1 2, 3 1 2, 3 1 2, 3 1 2, 3 1 2, 3 1 2, 3 1 2, 3 2 3 1 2, 3 1 2, 3 2 2 2 3 1 2, 3 2 2 2 3 2 2 2 2 3 2 2 2 2 2 2 2 2 2 2 2 2 2 |
| | Innut Offeet Current | $V_{CM} = 15V$ | | -0.4 | 0.4 | nA | 2, 3 |
| | Input Offset Current | | | -0.2 | 0.2 | nA | 1 |
| | | | | -0.4 | 0.4 | nA | 2, 3 |
| | | | | -0.2 | 0.2 | nA | 1 |
| | | $+V_{CC} = +5V, -V_{CC} = -5V$ | | -0.4 | 0.4 | nA | 2, 3 |
| Delta I _{IO} / | Temperature Coeffient of Input | $25^{\circ}C \le T_A \le +125^{\circ}C$ | See ⁽¹⁾ | -2.5 | 2.5 | pA/°C | 2 |
| Delta T | Offset Current | 25°C ≤ T _A ≤ -55°C | See ⁽¹⁾ | -2.5 | 2.5 | pA/°C | 3 |

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LM108A Electrical Characteristics DC Parameters (continued)

The following conditions apply to all the following parameters, unless otherwise specified. DC: $+V_{CC} = +20V$, $-V_{CC} = -20V$, $V_{CM} = 0V$, $R_S = 50\Omega$

| Symbol | Parameter | Conditions | Notes | Min | Max | Units | Sub- groups |
|------------------|------------------------------|--|--------------------|------|-----|-------|----------------|
| ±l _{IB} | | | | -0.1 | 2 | nA | 1 |
| | | $+V_{CC} = 35V, -V_{CC} = -5V,$ $V_{CM} = -15V$ | | -1 | 2 | nA | 2 |
| | | | | -0.1 | 3 | nA | 3 |
| | | | | -0.1 | 2 | nA | 1 |
| | | +V _{CC} = 5V, -V _{CC} = -35V, V _{CM} = 15V | | -1 | 2 | nA | 2 |
| | lanut Diag Current | | | -0.1 | 3 | nA | 3 |
| | Input Bias Current | | | -0.1 | 2 | nA | 1 |
| | | | | -1 | 2 | nA | 2 |
| | | | | -0.1 | 3 | nA | 3 |
| | | | | -0.1 | 2 | nA | 1 |
| | | $+V_{CC} = +5V, -V_{CC} = -5V$ | | -1 | 2 | nA | 2 |
| | | | | -0.1 | 3 | nA | 3 |
| +PSRR | Power Supply Rejection Ratio | $+V_{CC} = 10V, -V_{CC} = -20V$ | | -16 | 16 | μV/V | 1, 2, 3 |
| -PSRR | Power Supply Rejection Ratio | $+V_{CC} = 20V, -V_{CC} = -10V$ | | -16 | 16 | μV/V | 1, 2, 3 |
| CMRR | Common Mode Rejection Ratio | $V_{CM} = \pm 15V$ | | 96 | | dB | 1, 2, 3 |
| +I _{OS} | Short Circuit Current | $+V_{CC} = +15V, -V_{CC} = -15V, t \le 25mS$ | | -20 | | mA | 1, 2, 3 |
| -I _{OS} | Short Circuit Current | $+V_{CC} = +15V, -V_{CC} = -15V, t \le 25mS$ | | | 20 | mA | 1, 2, 3 |
| I _{CC} | | | | | 0.6 | mA | 1, 2 |
| | Power Supply Current | $+V_{CC} = +15V, -V_{CC} = -15V$ | | | 0.8 | mA | 3 |
| +V _{OP} | Output Voltage Swing | R _L = 10KΩ | | 16 | | V | 4, 5, 6 |
| -V _{OP} | Output Voltage Swing | R _L = 10KΩ | | | -16 | V | 4, 5, 6 |
| +A _{VS} | | | See ⁽²⁾ | 80 | | V/mV | 4 |
| | Open Loop Voltage Gain | $R_L = 10K\Omega, V_O = +15V$ | See ⁽²⁾ | 40 | | V/mV | 5, 6 |
| -A _{VS} | | | See ⁽²⁾ | 80 | | V/mV | 4 |
| | Open Loop Voltage Gain | $R_L = 10K\Omega, V_O = -15V$ | See ⁽²⁾ | 40 | | V/mV | 5, 6 |
| A _{VS} | Open Loop Voltage Gain | $+V_{CC} = \pm 5V, R_{L} = 10K\Omega, V_{O} = \pm 2V$ | See ⁽²⁾ | 20 | | V/mV | 4, 5, 6 |

(2) Datalog reading in K = V/mV





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LM108A Electrical Characteristics AC Parameters

The following conditions apply to all the following parameters, unless otherwise specified.

AC +V_{CC} = +20V, -V_{CC} = -20V, V_{CM} = 0V, R_{S} = 50\Omega

| Symbol | Parameter | Conditions | Notes | Min | Мах | Units | Sub- groups |
|------------------|------------------------------|--|-------|------|------|-------|----------------|
| TR _{TR} | Transient Response Rise Time | $\label{eq:RL} \begin{array}{l} R_L = 10 K \Omega, \ C_L = 100 p F, \\ f < 1 K H z, \ V_I = +50 m V \end{array}$ | | | 1000 | nS | 7, 8A, 8B |
| TR _{OS} | Transient Response Overshoot | $\label{eq:RL} \begin{array}{l} R_L = 10 K \Omega, \ C_L = 100 p F, \\ f < 1 K H z, \ V_I = +50 m V \end{array}$ | | | 50 | % | 7, 8A, 8B |
| +SR | Slew Rate | $A_V = 1, V_I = -5V \text{ to } +5V$ | | 0.05 | | V/µS | 7, 8A, 8B |
| -SR | Slew Rate | $A_V = 1, V_I = +5V \text{ to } -5V$ | | 0.05 | | V/µS | 7, 8A, 8B |
| NI _{BB} | Noise Broadband | BW = 10Hz to 5KHz, $R_S = 0\Omega$ | | | 15 | μVrms | 7 |
| NI _{PC} | Noise Popcorn | BW = 10Hz to 5KHz, $R_S = 100K\Omega$ | | | 40 | μVpk | 7 |

LM108A Electrical Characteristics DC Parameters Drift Values

The following conditions apply to all the following parameters, unless otherwise specified.

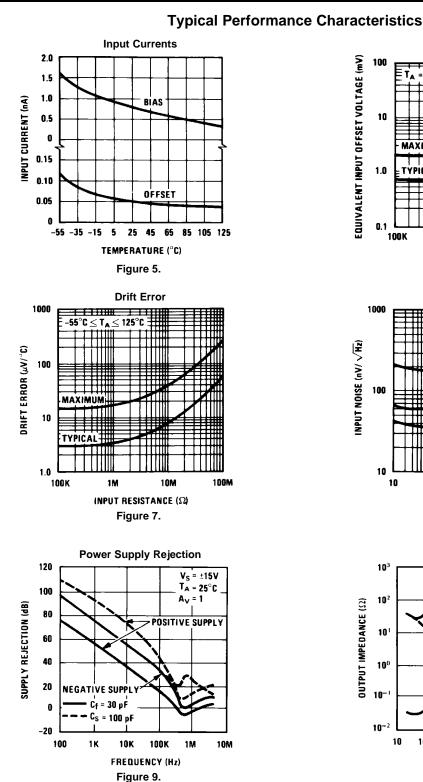
DC $+V_{CC} = +20V, -V_{CC} = -20V, V_{CM} = 0V, R_{S} = 50\Omega$

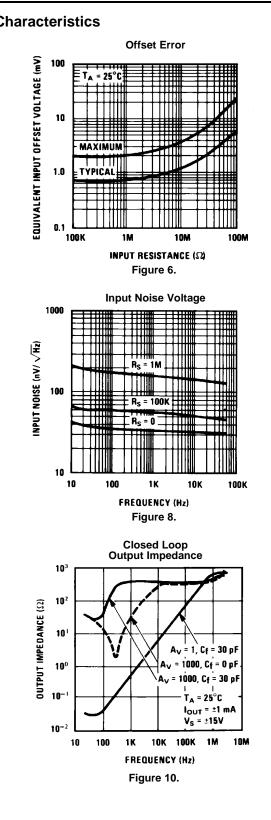
Delta calculations performed on JAN S devices at group B, Subgroup 5 only.

| Symbol | Parameter | Conditions | Notes | Min | Max | Units | Sub- groups |
|------------------|----------------------|------------|-------|-------|------|-------|----------------|
| V _{IO} | Input Offset Voltage | | | -0.25 | 0.25 | mV | 1 |
| ±I _{IB} | Input Bias Current | | | -0.5 | 0.5 | nA | 1 |

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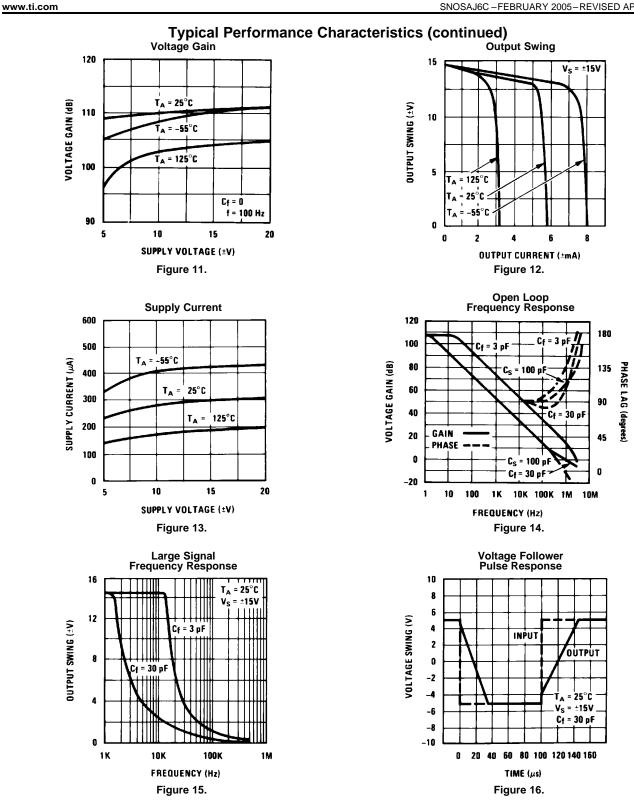




OBSOLETE



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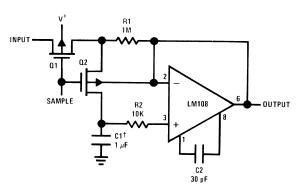


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 \dagger Teflon polyethylene or polycarbonate dielectric capacitor Worst case drift less than 2.5 mV/sec

Figure 17. Sample and Hold

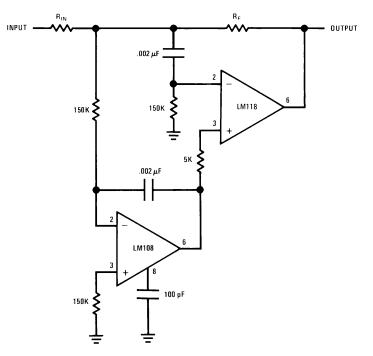
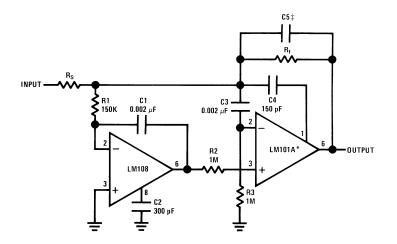


Figure 18. High Speed Amplifier with Low Drift and Low Input Current





$$\ddagger C5 = \frac{6 \times 10^{-8}}{\mathsf{R}_{\mathsf{f}}}$$

*In addition to increasing speed, the LM101A raises high and low frequency gain, increases output drive capability and eliminates thermal feedback.

Power Bandwidth: 250 KHzSmall Signal Bandwidth: 3.5 MHzSlew Rate: 10V/µS

Figure 19. Fast Summing Amplifier

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REVISION HISTORY

| Date Released | Revision | Section | Changes |
|---------------|----------|-------------------------------|--|
| 02/25/05 | А | New release, corporate format | 1 MDS data sheets converted into one Corp. datasheet format. MJLM108A-X Rev 2A0. MDS will be archived. |
| 01/05/06 | В | DC Electrical's | All temps. +Ios from -15 mA Min to -20 mA Min and - Ios from +15 mA Max to +20 mA Max |
| 09/24/10 | С | Obsolete Data Sheet | Revision C, End of Life on Product/NSID Dec. 2008/09 Obsolete Data Sheet |

| Changes from Revision E | 6 (April 2013) to | Revision C |
|-------------------------|-------------------|------------|
|-------------------------|-------------------|------------|

| Changed layout of National Data Sheet to TI format |
|--|
|--|

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